

Notice of References Cited

Application/Control No.

10/766,591

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

Chrystina Zelaskiewicz

Art Unit

4143

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0050114	03-2003	Leen et al.	463/25
*	B	US-6,758,754	07-2004	Lavanchy et al.	463/42
*	C	US-7,086,947	08-2006	Walker et al.	463/25
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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